

ZXMP4A16K 40V P-channel enhancement mode MOSFET

Summary

 $V_{(BR)DSS}$ = -40V; $R_{DS(ON)}$ = 0.060 Ω I_{D} = -9.9A

Description

This new generation of trench MOSFETs from Zetex utilizes a unique structure that combines the benefits of low on-resistance with fast switching speed. This makes them ideal for high efficiency, low voltage, power management applications.



Features

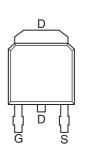
- · Low on-resistance
- · Fast switching speed
- · Low threshold
- · Low gate drive
- · DPAK package

Applications

- DC DC converters
- · Audio output stages
- · Relay and solenoid driving
- Motor control

Ordering information

| Device | Reel size (inches) | Tape width | Quantity per reel |
|-------------|--------------------|------------|-------------------|
| ZXMP4A16KTC | 13 | 16mm | 2500 units |

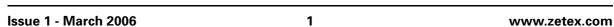


Pinout - Top view

Device marking

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ZXMP 4A16



Absolute maximum rating

| Parameter | Symbol | Limit | Unit | |
|--|----------------------------------|--------------|------------|--|
| Drain-source voltage | V _{DSS} | -40 | V | |
| Gate-source voltage | V _{GS} | ±20 | V | |
| Continuous drain current | | | | |
| V _{GS} = -10V; T _A =25°C ^(b) | | -9.9 | Α | |
| V _{GS} = -10V; T _A =70°C ^(b) | I _D | -8.0 | Α | |
| V_{GS} = -10V; T_A =25°C ^(a) | | -6.6 | Α | |
| Pulsed drain current (c) | I _{DM} | -35 | Α | |
| Continuous source current (body diode) (b) | I _S | -10.1 | Α | |
| Pulsed source current (body diode) (c) | I _{SM} | -35 | Α | |
| Power dissipation at T _A =25°C ^(a) | P _D | 4.2 | W | |
| Linear derating factor | | 33.6 | mW/°C | |
| Power dissipation at T _A =25°C ^(b) | P _D | 9.5 | W | |
| Linear derating factor | | 76 | mW/°C | |
| Power dissipation at T _A =25°C ^(d) Linear derating factor | P _D | 2.15 17.2 | W mW/°C | |
| Operating and storage temperature range | T _j :T _{stg} | -55 to +150 | °C | |
| Thermal resistance | | | | |
| Parameter | Symbol | Value | Unit | |
| Junction to ambient ^(a) | $R_{\Theta JA}$ | 30 | °C/W | |
| Junction to ambient ^(b) | $R_{\Theta JA}$ | 13.2 | °C/W | |
| Junction to ambient ^(d) | $R_{\Theta JA}$ | 58 | °C/W | |

NOTES:

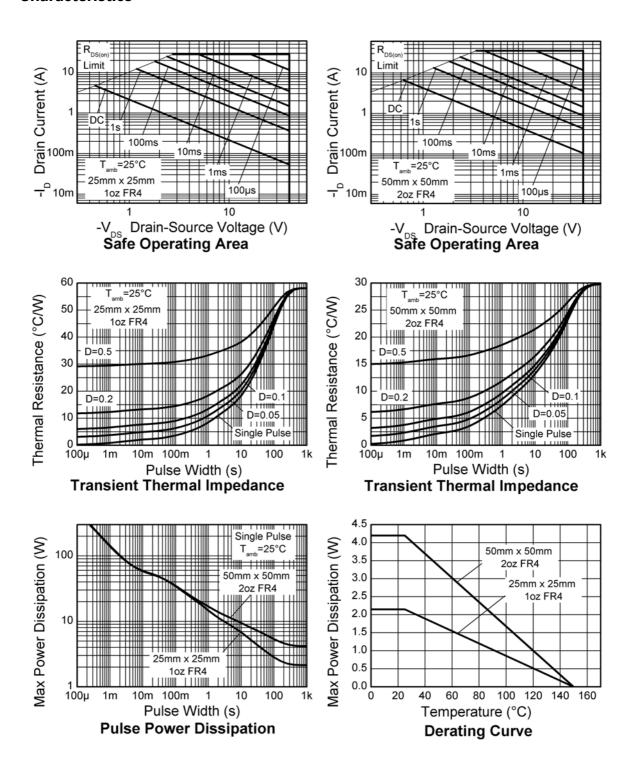
⁽a) For a device surface mounted on 50mm x 50mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions.

⁽b) For a device surface mounted on FR4 PCB measured at t $\leq\!10$ sec.

⁽c) Repetitive rating 50mm x 50mm x 1.6mm FR4 PCB, D=0.02 pulse width=300 \(\mu \)s - pulse width limited by maximum junction temperature.

⁽d) For a device surface mounted on 25mm x 25mm x 1.6mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

Characteristics



Electrical characteristics (at $T_A = 25$ °C unless otherwise stated)

| Parameter | Symbol | Min. | Тур. | Max. | Unit | Conditions | |
|---------------------------------|----------------------|------|-------|-------|----------|---|--|
| Static | | | | | | | |
| Drain-source breakdown voltage | V _{(BR)DSS} | -40 | | | V | I _D =-250μA, V _{GS} =0V | |
| Zero gate voltage drain current | I _{DSS} | | | -1 | μΑ | V _{DS} =-40V, V _{GS} =0V | |
| Gate-body leakage | I _{GSS} | | | 100 | nA | $V_{GS} = \pm 20V, V_{DS} = 0V$ | |
| Gate-source threshold voltage | V _{GS(th)} | -1.0 | | | V | I_D =-250 μ A, V_{DS} = V_{GS} | |
| Static drain-source on-state | R _{DS(on)} | | | 0.060 | Ω | V _{GS} =-10V, I _D =-3.8A | |
| resistance (*) | | | | 0.100 | Ω | V_{GS} =-4.5V, I_{D} =-2.9A | |
| Forward transconductance (*)(‡) | 9 _{fs} | | 7.4 | | S | V _{DS} =-15V,I _D =-3.8A | |
| Dynamic (‡) | | | | | | • | |
| Input capacitance | C _{iss} | | 965 | | pF | | |
| Output capacitance | C _{oss} | | 180 | | pF | V_{DS} =-20V, V_{GS} =0V, ==1MHz | |
| Reverse transfer capacitance | C _{rss} | | 158 | | pF | | |
| Switching (†) (‡) | | | | | | • | |
| Turn-on delay time | t _{d(on)} | | 4.0 | | ns | | |
| Rise time | t _r | | 6.0 | | ns | V _{DD} =-20V, I _D =-1A | |
| Turn-off delay time | t _{d(off)} | | 36.8 | | ns | $R_G=6.0\Omega, V_{GS}=-10V$ | |
| Fall time | t _f | | 17.1 | | ns | | |
| Gate charge | Q_g | | 16.5 | | nC | V_{DS} =-20V, V_{GS} =-5V, I_{D} =-3.8A | |
| Total gate charge | Qg | | 29.6 | | nC | | |
| Gate-source charge | Q _{gs} | | 2.8 | | nC | V _{DS} =-20V,V _{GS} =-10V, I _D =-3.8A | |
| Gate-drain charge | Q_{gd} | | 8.1 | | nC | - 1D3.0A | |
| Source-drain diode | | | | | | | |
| Diode forward voltage (*) | V _{SD} | | -0.89 | -1.2 | V | T _J =25°C, I _S =-3.8A, V _{GS} =0V | |
| Reverse recovery time (‡) | t _{rr} | | 29.8 | | ns | T _J =25°C, I _F =-3.8A, | |
| Reverse recovery charge (‡) | Q _{rr} | | 37.2 | | nC | di/dt= 100A/μs | |

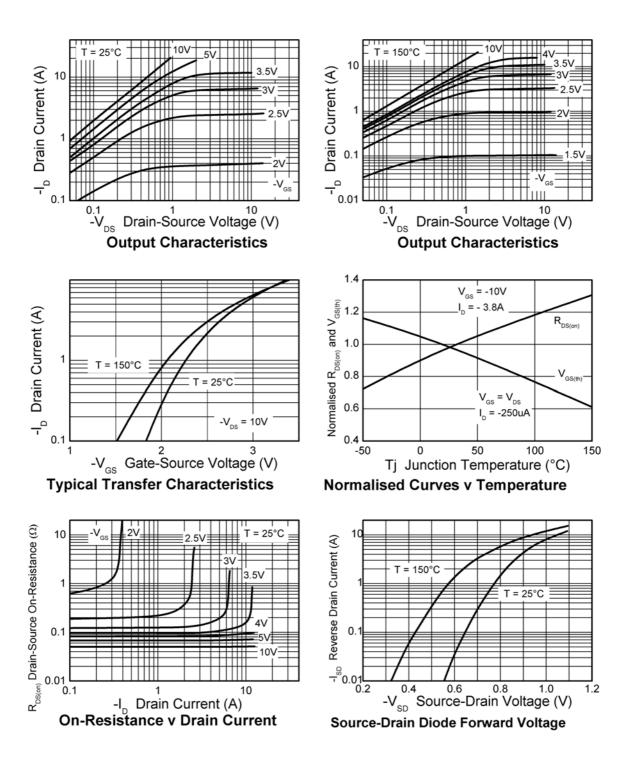
NOTES:

^(*) Measured under pulsed conditions. Width \leq 300µs. Duty cycle \leq 2%.

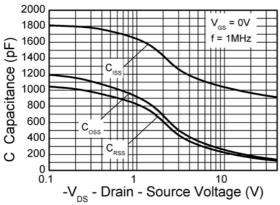
^(†) Switching characteristics are independent of operating junction temperature.

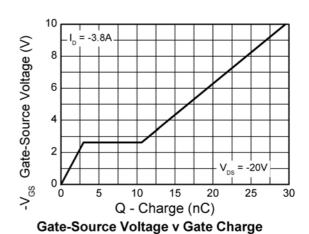
^(‡) For design aid only, not subject to production testing.

Typical characteristics

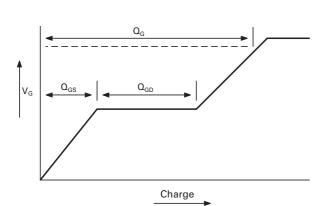


Typical characteristics





Capacitance v Drain-Source Voltage



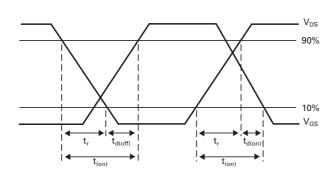
Current regulator

12V 0.2µF 50k Same as D.U.T

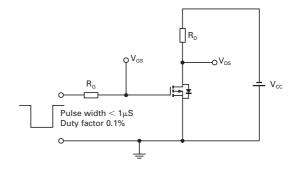
V_{DS}

V_D

Basic gate charge waveform



Gate charge test circuit



Switching time waveforms

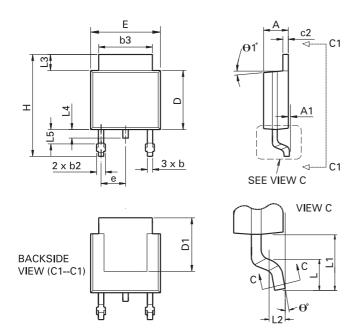
Switching time test circuit

ZXMP4A16K

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ZXMP4A16K

Package details - DPAK



Package dimensions

| Dim. | Inc | hes | Millin | Millimeters Dim. Inches Millime | | Inches | | neters | |
|------|-------|-------|--------|---------------------------------|------------|-----------|-------|----------|-------|
| | Min. | Max. | Min. | Max. | | Min. | Max. | Min. | Max. |
| Α | 0.086 | 0.094 | 2.18 | 2.39 | е | 0.090 BSC | | 2.29 BSC | |
| A1 | = | 0.005 | - | 0.127 | Н | 0.370 | 0.410 | 9.40 | 10.41 |
| b | 0.020 | 0.035 | 0.508 | 0.89 | L | 0.055 | 0.070 | 1.40 | 1.78 |
| b2 | 0.030 | 0.045 | 0.762 | 1.14 | L1 | 0.108 | REF | 2.74 | REF |
| b3 | 0.205 | 0.215 | 5.21 | 5.46 | L2 | 0.020 | BSC | 0.508 | BSC |
| С | 0.018 | 0.024 | 0.457 | 0.61 | L3 | 0.035 | 0.065 | 0.89 | 1.65 |
| c2 | 0.018 | 0.023 | 0.457 | 0.584 | L4 | 0.025 | 0.040 | 0.635 | 1.016 |
| D | 0.213 | 0.245 | 5.41 | 6.22 | L5 | 0.045 | 0.060 | 1.14 | 1.52 |
| D1 | 0.205 | - | 5.21 | - | Ө1° | 0° | 10° | 0° | 10° |
| Е | 0.250 | 0.265 | 6.35 | 6.73 | θ° | 0° | 15° | 0° | 15° |
| E1 | 0.170 | - | 4.32 | - | _ | - | - | - | - |

Note: Controlling dimensions are in inches. Approximate dimensions are provided in millimeters

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